## **STW70N65M2**



# N-channel 650 V, 0.039 Ω typ., 63 A MDmesh™ M2 Power MOSFET in a TO-247 package

Datasheet - production data

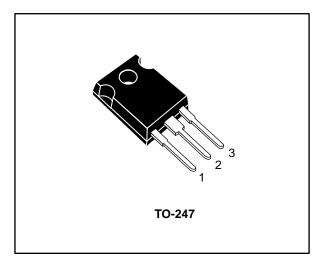
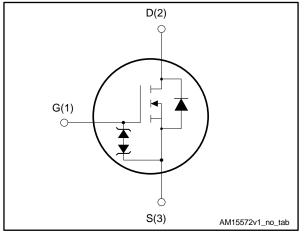


Figure 1: Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STW70N65M2	650 V	0.046 Ω	63 A

- Extremely low gate charge
- Excellent output capacitance (C<sub>OSS</sub>) profile
- 100% avalanche tested
- Zener-protected

### **Applications**

Switching applications

### **Description**

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

Table 1: Device summary

Order code	Marking	Package	Packaging
STW70N65M2	70N65M2	TO-247	Tube

Contents STW70N65M2

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STW70N65M2 Electrical ratings

# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>GS</sub>	Gate-source voltage	± 25	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	63	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	40	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	252	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	446	W
dv/dt (2)	Peak diode recovery voltage slope	15	V/ns
dv/dt (3)	MOSFET dv/dt ruggedness	50	V/ns
T <sub>stg</sub>	Storage temperature range	55 to 150	°C
Tj	Operating junction temperature range - 55 to 150		°C

#### Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.28	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	50	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetetive or not repetetive (pulse width limited by $T_{\text{jmax}}$ )	4	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_j$ = 25 °C, $I_D$ = $I_{AR}$ , $V_{DD}$ = 50 V)	3500	mJ

 $<sup>\</sup>ensuremath{^{(1)}}\mbox{Pulse}$  width limited by safe operating area.

 $<sup>^{(2)}</sup>$   $I_{SD} \leq 63$  A, di/dt  $\leq 400$  A/µs;  $V_{DS\;peak} < V_{(BR)DSS}, \, V_{DD} = 400$  V

<sup>(3)</sup> V<sub>DS</sub> ≤ 520 V

Electrical characteristics STW70N65M2

## 2 Electrical characteristics

(T<sub>C</sub>= 25 °C unless otherwise specified)

Table 5: On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			V
	Zoro goto voltago droin	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$			1	μΑ
I <sub>DSS</sub>	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V},$ $T_{C} = 125 \text{ °C}^{(1)}$			100	μΑ
I <sub>GSS</sub>	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±5	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 31.5 A		0.039	0.046	Ω

#### Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions		Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	5140	ı	pF
Coss	Output capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz,	-	208	ı	pF
C <sub>rss</sub>	Reverse transfer capacitance	$V_{GS} = 0 V$	-	2.9	-	pF
Coss eq. (1)	Equivalent output capacitance	V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V	-	520	-	pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz, I <sub>D</sub> =0 A	-	3	1	Ω
Qg	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 63 \text{ A},$	-	117	1	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V (see Figure 15: "Test circuit for gate charge	-	21.5	1	nC
$Q_{gd}$	Gate-drain charge	behavior")	-	51	-	nC

#### Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = 325 \text{ V}, I_D = 31.5 \text{ A}$	-	24	-	ns
t <sub>r</sub>	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 V$ (see Figure 14: "Test circuit for		22	1	ns
t <sub>d(off)</sub>	Turn-off-delay time	resistive load switching times" and	1	134	ı	ns
t <sub>f</sub>	Fall time	Figure 19: "Switching time waveform")		11	ı	ns

 $<sup>^{(1)}</sup>$ Defined by design, not subject to production test.

 $<sup>^{(1)}</sup>$ Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS

Table 8: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		ı		63	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)				252	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 63 A			1.6	V
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 63 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	ı	584		ns
Q <sub>rr</sub>	Reverse recovery charge	$V_{DD} = 60 \text{ V}$ (see Figure 16: "Test circuit for	1	14.5		μC
I <sub>RRM</sub>	Reverse recovery current	inductive load switching and diode recovery times")	ı	50.5		Α
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 63 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	ı	725		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 \text{ °C}$ (see Figure 16: "Test circuit for	-	20		μC
I <sub>RRM</sub>	Reverse recovery current	inductive load switching and diode recovery times")	-	55.5		Α

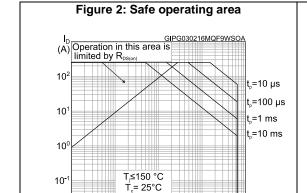
#### Notes:

 $<sup>^{(1)}</sup>$ Pulse width is limited by safe operating area

 $<sup>^{(2)}\</sup>text{Pulse}$  test: pulse duration = 300  $\mu\text{s},$  duty cycle 1.5%

 $\vec{V}_{DS}(V)$ 

## 2.2 Electrical characteristics (curves)



single pulse

10<sup>1</sup>

10<sup>-2</sup>

10

Figure 3: Thermal impedance

K

-0.2

-0.2

-0.05

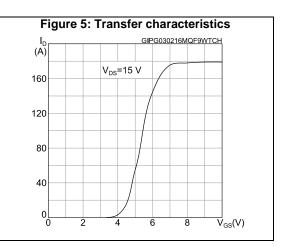
The impedance

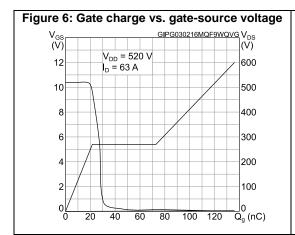
AM09125v1

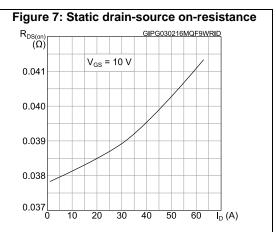
Zth=k Rthj-c
d=tp/t

10<sup>-1</sup>

10<sup>-</sup>







STW70N65M2 Electrical characteristics

Figure 8: Capacitance variations

C
(pF)

10<sup>4</sup>

10<sup>3</sup>

10<sup>2</sup>

10<sup>1</sup>

f = 1 MHz

C<sub>RSS</sub>

10<sup>0</sup>

10<sup>-1</sup>

10<sup>0</sup>

10<sup>1</sup>

10<sup>2</sup>

V<sub>DS</sub> (V)

Figure 10: Normalized on-resistance vs temperature

R<sub>DS(on)</sub> GIPG030216MQF9WRON
(norm.)

2.2

1.8

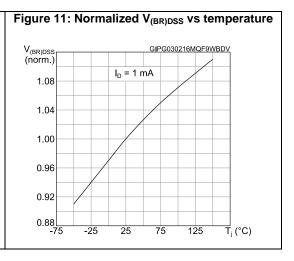
1.4

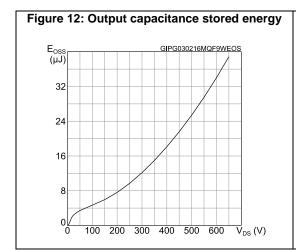
1.0

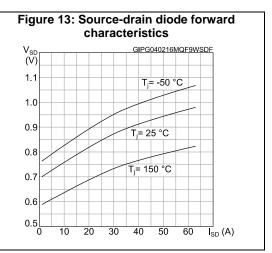
0.6

0.2

-75 -25 25 75 125 T<sub>j</sub> (°C)







Test circuits STW70N65M2

## 3 Test circuits

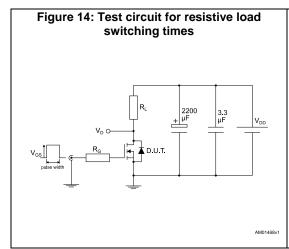


Figure 15: Test circuit for gate charge behavior

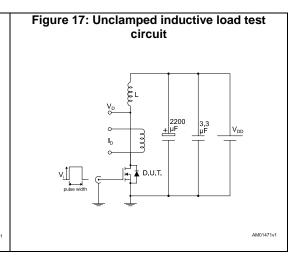
12 V 47 kΩ 100 nF 1 kΩ

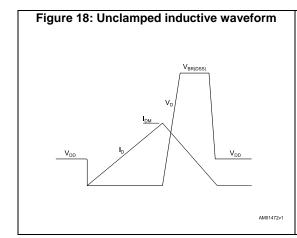
Vos 1 kΩ 1 kΩ

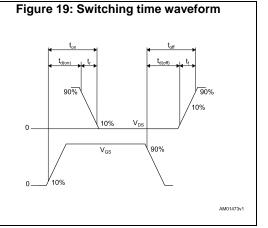
Vos 1 kΩ 1 kΩ

AM01469v1

Figure 16: Test circuit for inductive load switching and diode recovery times







## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

### 4.1 TO-247 package information

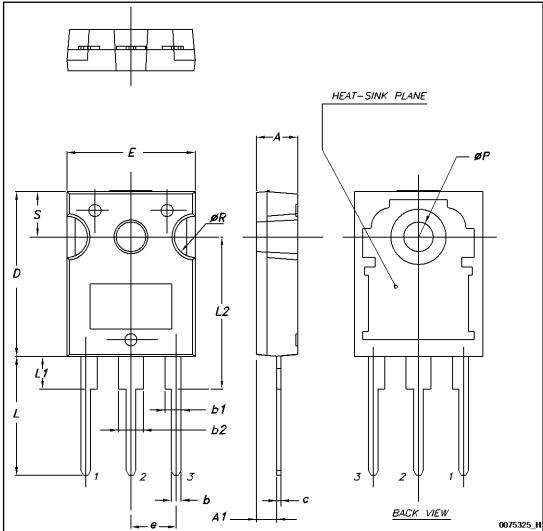


Figure 20: TO-247 package outline

Table 9: TO-247 package mechanical data

Dim	•	mm.	
Dim.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
Е	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

STW70N65M2 Revision history

# 5 Revision history

Table 10: Document revision history

Date	Revision	Changes
04-Feb-2016	1	First release.

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